Notice of References Cited

Application/Control No. 10/658,140	Applicant(s)/Patent Under Reexamination FRANK ET AL.	
Examiner	Art Unit	
Van Kim T. Nguyen	2661	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,768,726	07-2004	Dorenbosch et al.	370/331
	В	US-6,747,968	06-2004	Seppala et al.	370/338
	O	US-6,657,981	12-2003	Lee et al.	370/331
	D	US-6,611,547	08-2003	Rauhala, Kristian	370/331
	Е	US-2004/0063455	04-2004	Eran et al.	455/525
	F	US-2004/0068668	04-2004	Lor et al.	713/201
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	Κ	US-			
	L	US-		·	
	М	US-			

FOREIGN PATENT DOCUMENTS

*	<u> </u>	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

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